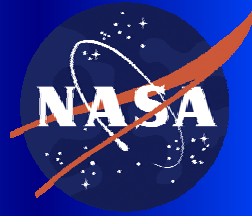


NASA Technology Days Overview Briefing



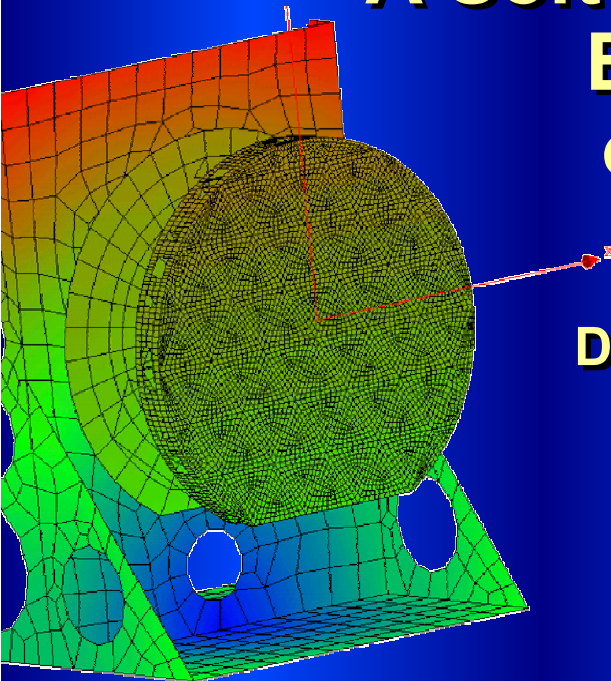
for

IODA

(Integrated Optical Design Analysis)

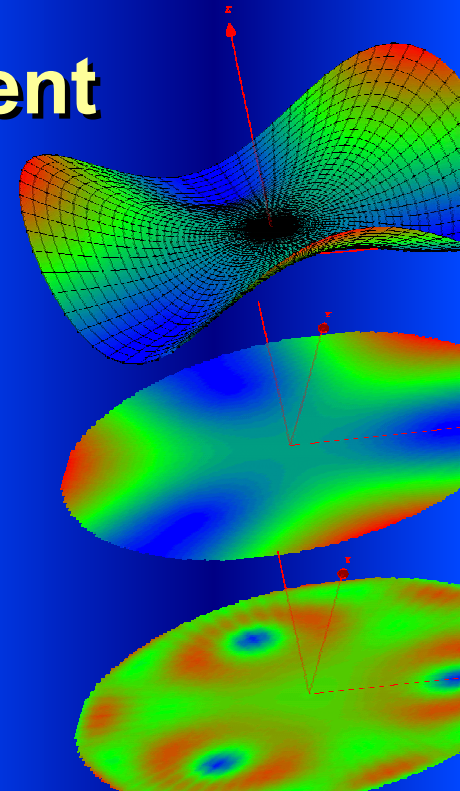
New Features and Improvements

A Software Tool for Concurrent Engineering Design of Optical Systems



24 May 2002
Developed Under Contract No.
NAS8-0005

Presented by Jim Moore
256-971-7020



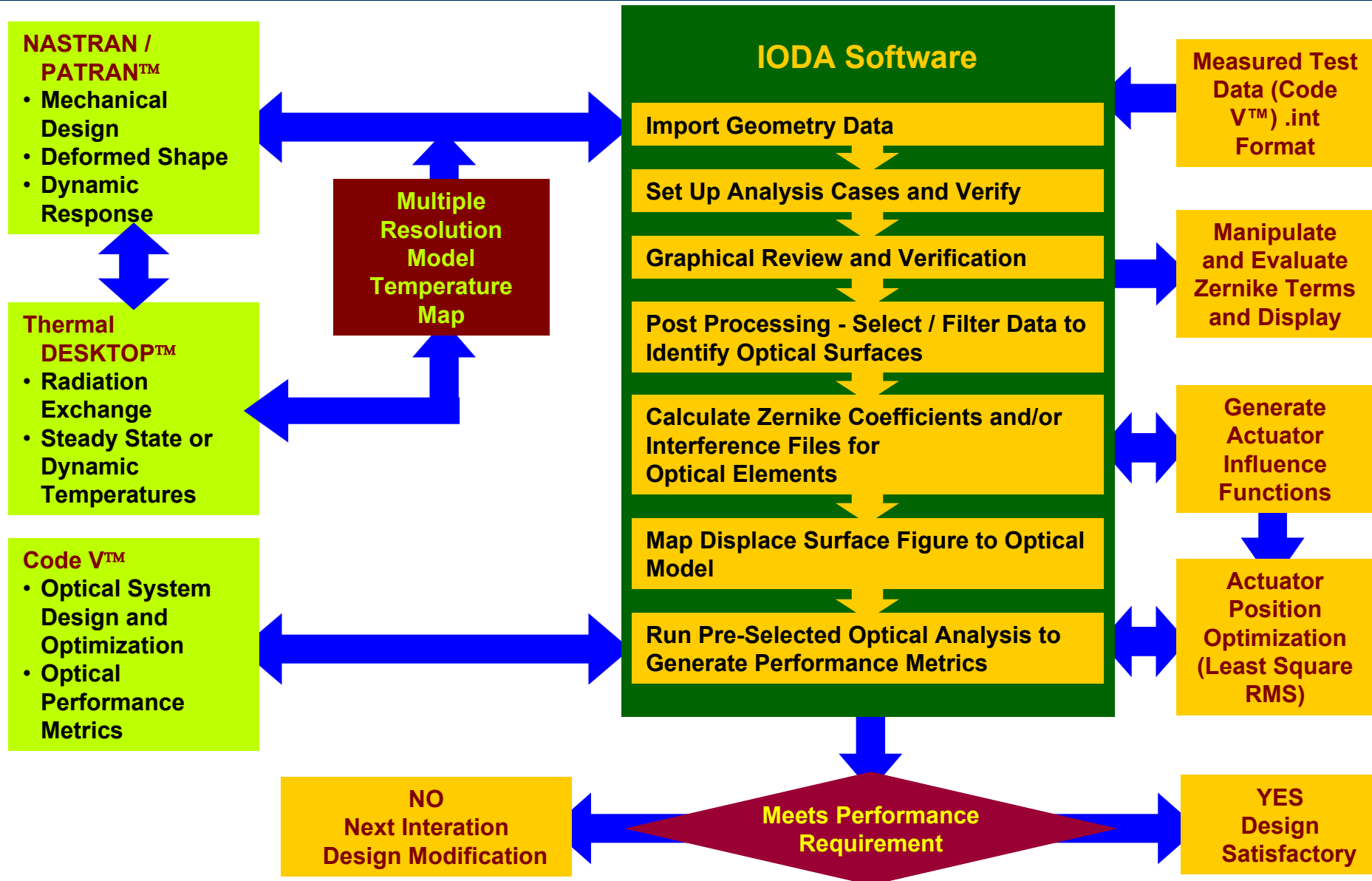
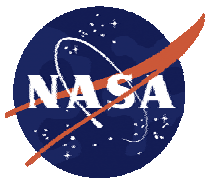
Integrated Modeling Approach

**Integrated Optical Design Analysis (IODA) Software
Simplifies and Automates Data Sharing for Concurrent
Design by a Diverse Team of Engineering Specialist**

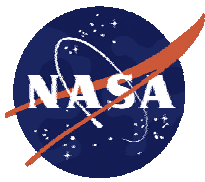
Topics

- **Code Description and Model Interactions**
- **Summary of Features**
- **Actuator Influence Functions**
- **Figure Optimization Using Influence Functions**
- **Measured Data Import and Data Post Processing**
- **Dynamic Image Analysis**
- **Summary**

Schematic of Data Flow and Software Interactions

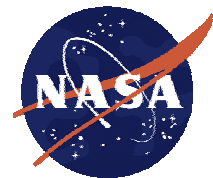


Summary of IODA Features

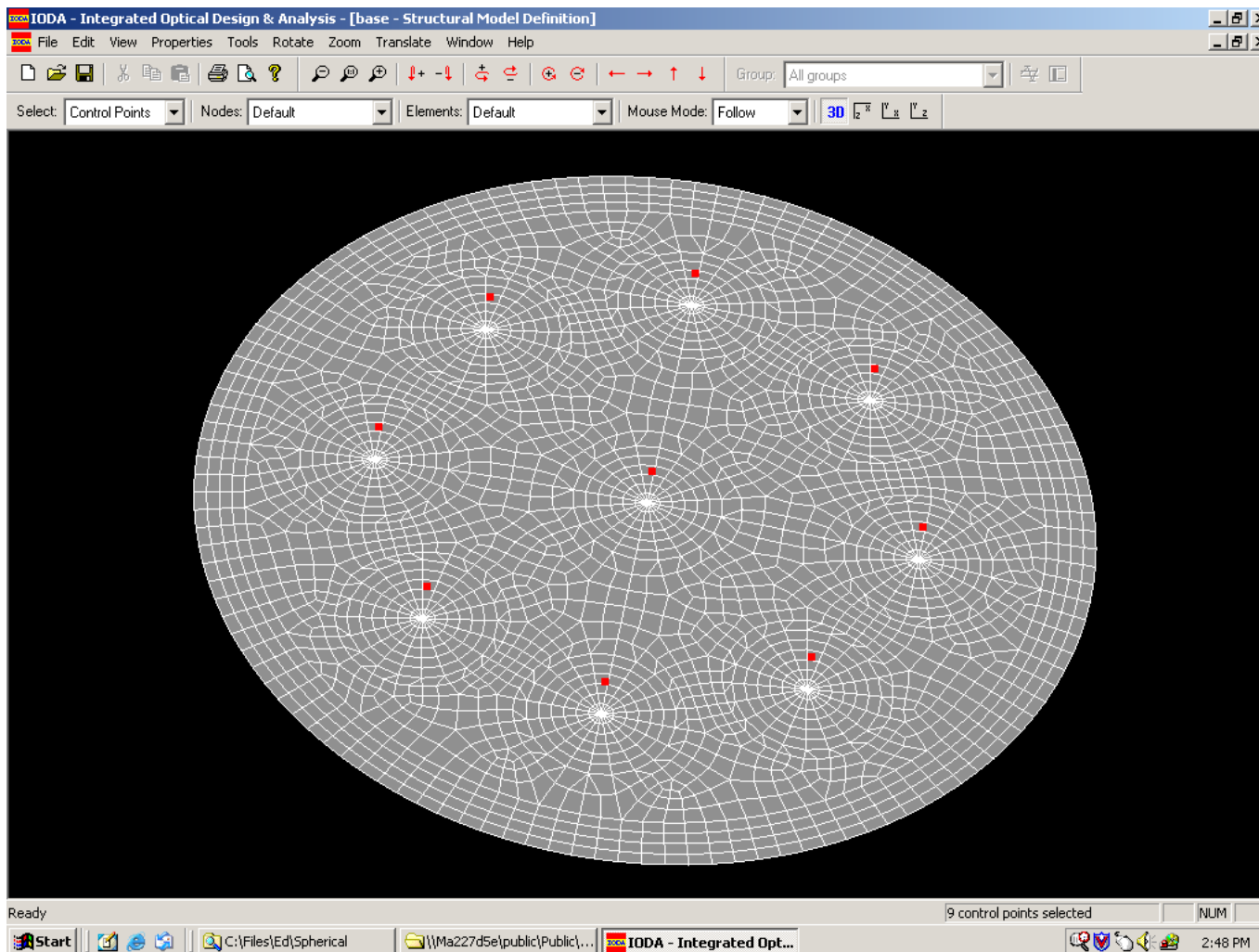


- **Transfer Optical Surface Deflections from FEA to Code V™ for coupled Optomechanical Analysis**
 - **Select and Group Optical Surface Nodes**
 - **Map Optical Surface Deflections to a Uniform Grid as Required for Optical Model Definition**
 - **Generate Zernike Polynomials and/or Interferogram Files for Optical Model**
 - **Map Deformations into Optical Model Surfaces (Multiple Flexible Surfaces)**
- **Generate Parametric Analysis from Multiple Load Cases**
- **Automated Macros For Generating Most of the Optical Metrics versus Load Case**
- **Data Post Processing and Decomposition into Zernike Terms**
- ***ALGOR Interface Developed for Linear and Non-Linear FEA***
- ***Automated Generation of Influence Functions For Optical Surfaces***
- ***Least Squares Routine Developed to Solve for Actuator Positions to Minimize RMS Figure Error***
- ***Comparison of Measured Data to Modeled Data and Multiple Load Cases to Each Other***
- ***Dynamic Analysis Capability Added to Generate Wavefront and Image Analysis for Dynamic Loading***

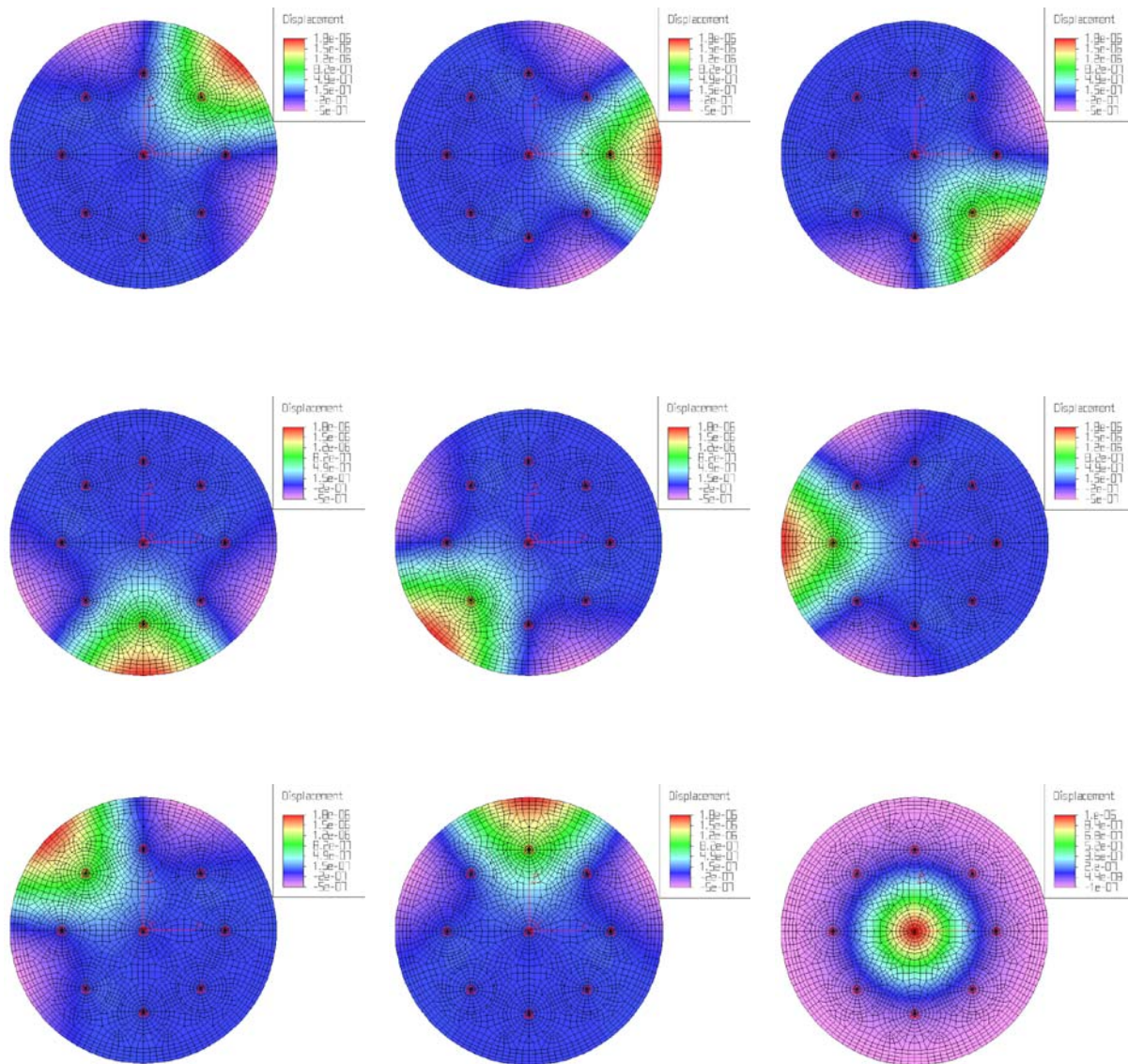
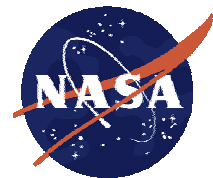
Automated Generation of Actuator Influence Functions



- **Point-And-Click Interface Developed for Selecting Actuator Points and Creating Influence Functions**
- **Variable Stiffness Actuators Modeled Using SPCD in NASTRAN or Boundary Element in ALGOR**
- **Actuator Stroke in Optical Axis or User Defined Local Coordinate System**
- **Generates Influence Function for Each Actuator and Each Surface Node Included in IODA Optical Group**

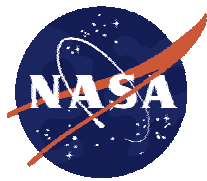


Influence Coefficients Generated for Spherical Mirror Model



- IODA Generates Influence Coefficients for Each Node Selected As a Control Point
- Generates and Stores I Matrix (Number of Control Points by Number of Surface Nodes) for Optimization Routine
- User Specified Actuator Stroke
- Influence Functions Can Be Generated for Any IODA Group

Least Squares Routine Developed for Figure Optimization Using Influence Functions



\bar{e} = Inverse of Initial Error Vector

$[I]$ = Influence Matrix

\bar{P} = Actuator Position Vector

Least Squares Solution for P
Generated by Solving...

$$\bar{P} = [I^T I]^{-1} [I^T] e$$

δ_i = Nodal Deflection for Optical Surface
Nodes

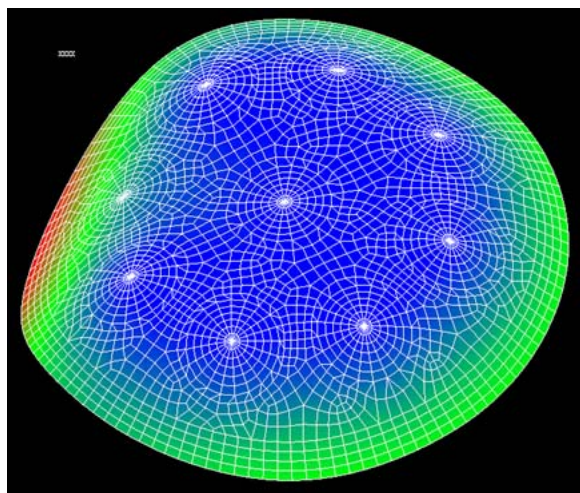
P = Actuator Positions That Satisfy

$$\sum_{i=1}^n (\delta_i - e_i)^2 = \text{Minimum}$$

Final Figure Calculated by
Superimposing Initial Deflections with
Deflections from Corrected Case

Note: Current Analysis Gives Each Node
Equal Weighting; Weighting Function
Options Under Development

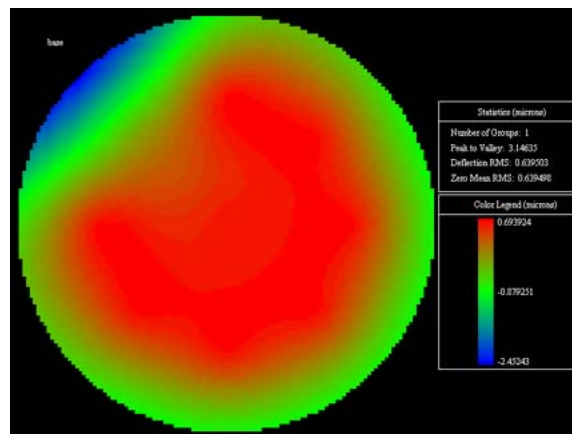
Figure Optimization Using IODA Influence Function and Least Squares Routine



RMS
0.639 μ
P.V.
3.14 μ

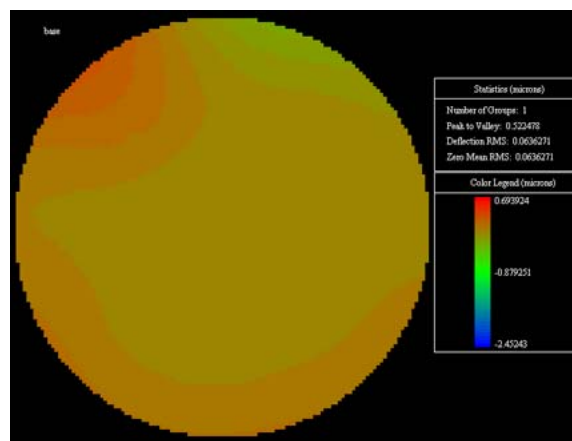
Modeled Error Source (Gravity and Actuator Position Error)

- 1-G Load in Optical Axis Direction
- 0.8 Micron Actuator Error on Actuator 7
- Deformation Scaling 50,000



Uncorrected Figure

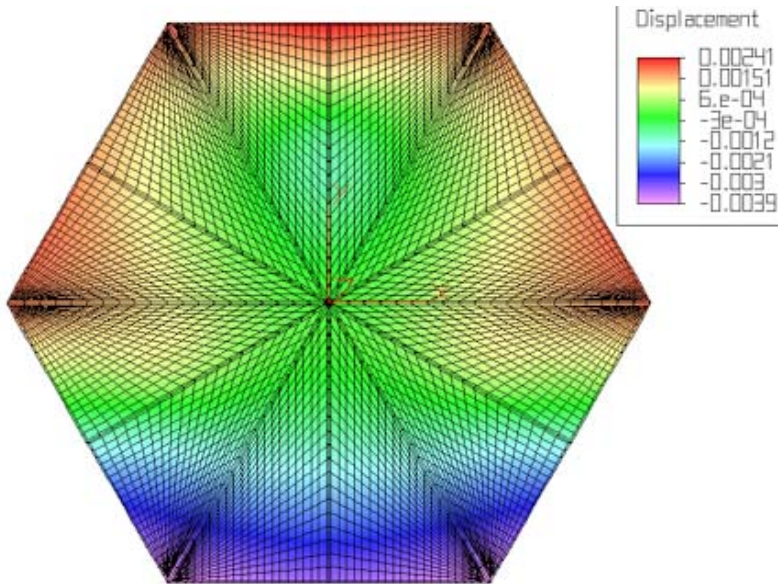
RMS
0.063 μ
P.V.
0.522 μ



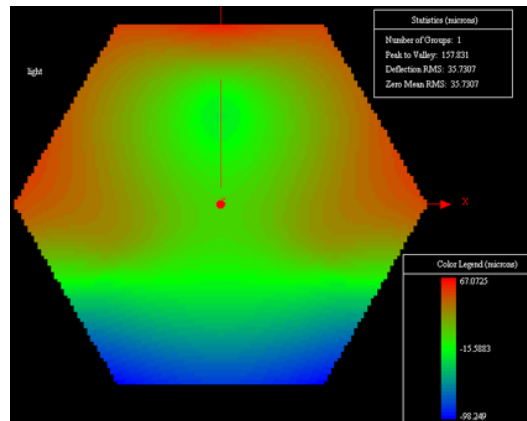
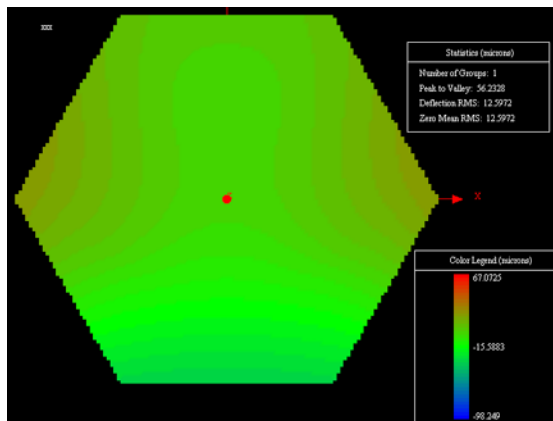
Corrected Figure

Optimized Actuator Positions

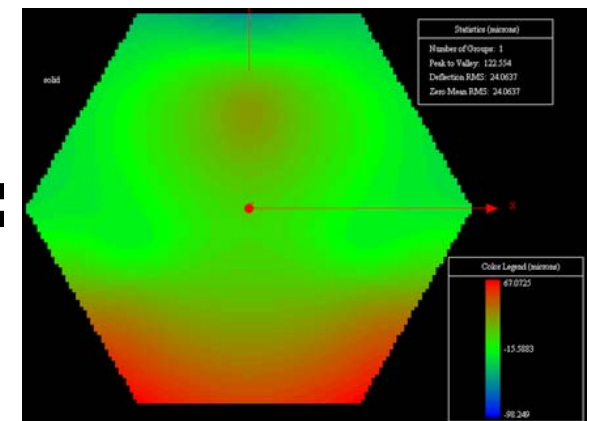
Number	Position (in x 10 ⁻⁵)
1	2.004
2	2.000
3	2.004
4	1.986
5	2.004
6	2.000
7	5.504
8	1.986
9	-2.793



- Evaluate Effects of Mirror Mount Changes, Material Substitutions or Design Changes
- Characterize the Nature of Changes Using Zernike Polynomial Fit Tools
- Supports Model to Model Comparison and Model to Measured Data Comparison

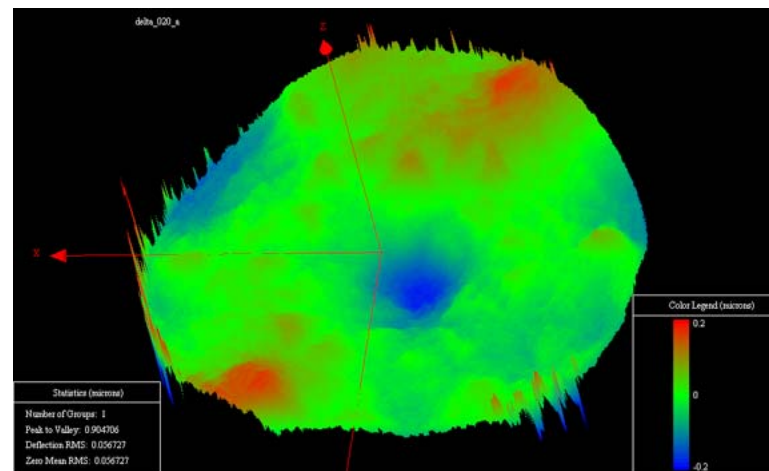


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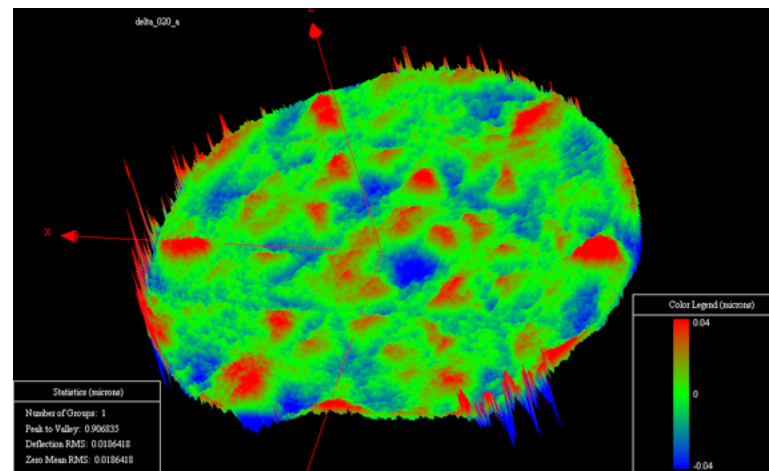


Measured Data Import and Post Processing Features

- Import Capability for Code V™ Compatible .int File From Measured Data (Uniform Grid or Zernike Formats)
- Data Can Be Fit and Manipulated Using IODA Zernike Routines
- Measured Data Can Be Subtracted From Model Results for Comparison
- Zernike Modeling of Differences Files
- Averaging of Multiple Data Sets



Example Data Input
From XRCF Test



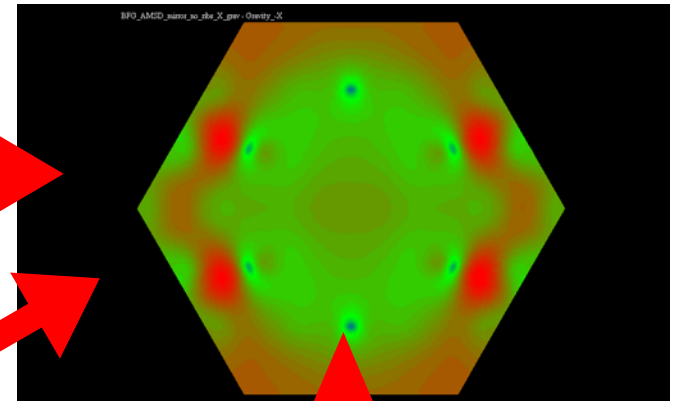
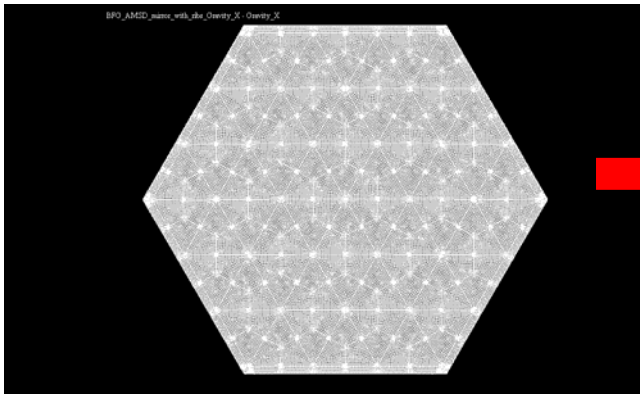
Imported Data File With 43 WaveScope
Zernike Coefficients Removed

Dynamic Image and Wavefront Analysis

NASTRAN Model

- Direct Transient Response (SOL 109)
 - Model Transient Response (SOL 112)
- Displacement Output at User Specified Intervals

IODA Model Extracts Surface Deflections, Creates Code V .int Files, and Dynamically Updates Optical Model



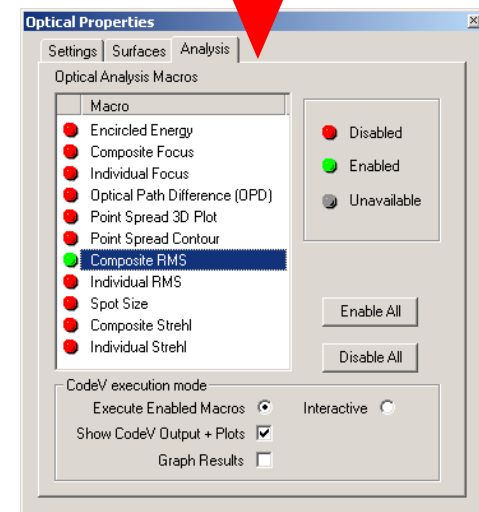
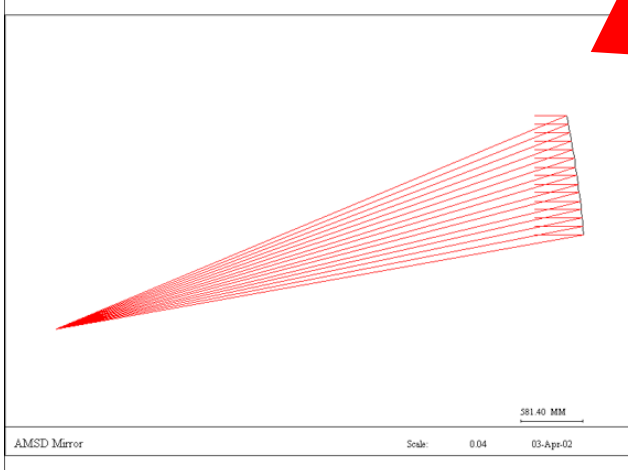
Geometry

Deflections
(Time = 0 - Max)

.int Files

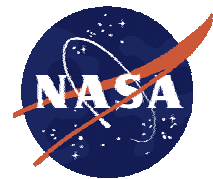
Raytraces
(One Iteration per
Time Step)

Code V Model Raytrace and Wavefront Analysis

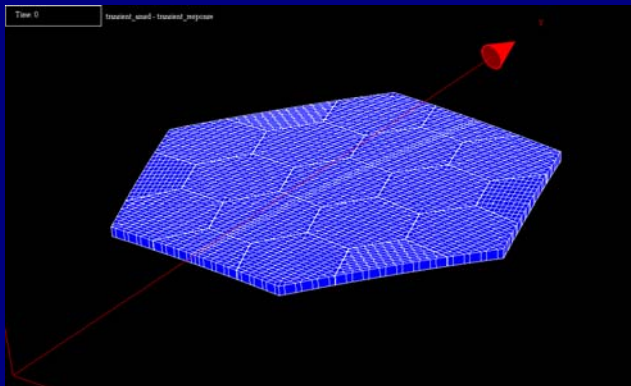


Output
of Time
Depen-
dent
Optical
Results

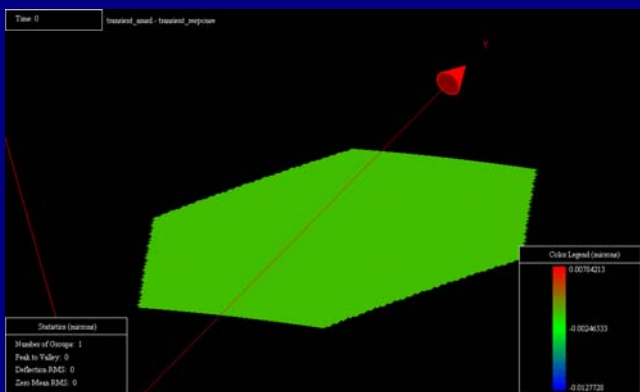
Image Analysis Including System Dynamic Response



NASTRAN Dynamic Response Analysis

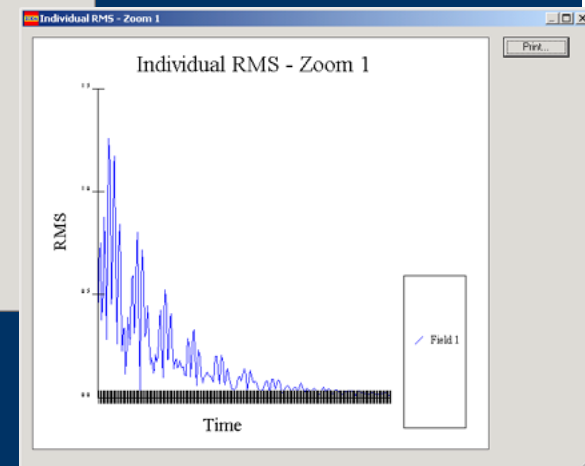
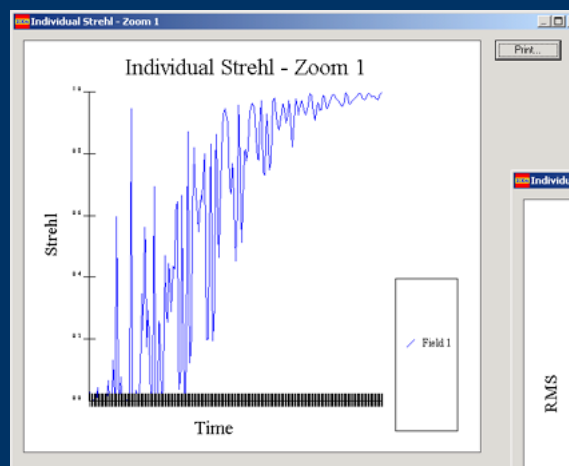


Nodal Displacement

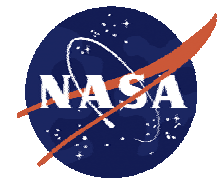


IODA Generated Uniform Grid File

- IODA Processes Data From Dynamic Finite Element Analysis at Frequency of FEA Output
- Each IODA Optical Group's Time Dependent Displacements Are Mapped to Code V™ Sequence File
- Code V™ Macro List Is Supported to Generate Time Dependent Performance Metrics



Summary



- **IODA Provides a User Friendly Graphical Interface Between Thermomechanical and Optical Analysis Tools**
- **Eliminates Many Potential Error Sources and Reduces Time Required for Integrated Modeling**
- **New Features Being Developed to Support AMSD Testing at MSFC**
 - **Actuator Influence Functions**
 - **Figure Optimization**
 - **Direct Import of Measured Optical Data**
 - **Dynamic Analysis Capability**
- **Demonstration Copies Available**